John The Ch the chief of

7 P.

NASA Technical Memorandum 106687

Defocus Measurement Using a Liquid Crystal Point Diffraction Interferometer

Carolyn R. Mercer Lewis Research Center Cleveland, Ohio

and

Katherine Creath University of Arizona Tucson, Arizona

Prepared for the Optical Fabrication and Testing Workshop sponsored by the Optical Society of America Rochester, New York, June 6–9, 1994



National Aeronautics and Space Administration

N95-12748	unclas	0027034
		63/35
NASA-TM-106687) DEFOCUS	AEASUREMENT USING A LIQUIU UNISTAL POINT DIFFRACTION INTERFEROMETER (NASA. Lewis Research Center) 7 p	

## Defocus Measurement Using A Liquid Crystal Point Diffraction Interferometer

Carolyn R. Mercer NASA Lewis Research Center, Cleveland, OH 44135 ph: 216-433-3411 fax: 216-433-8643

> Katherine Creath Optical Sciences Center University of Arizona, Tucson, AZ 85721 ph: 602-621-8688 fax: 602-621-3389

# Introduction

A liquid crystal phase-stepped point diffraction interferometer (LCPDI) has been developed to measure optical wavefronts[1]. A locally generated reference beam is generated by diffraction from a microsphere embedded in a thin liquid crystal layer. Phase shifting is achieved by applying a voltage across the birefringent liquid crystals to shift the phase of the object beam without affecting the reference beam. The intended application for this instrument is the measurement of phase objects, such as optical elements and slowly varying fluids.

In flow metrology, wavefronts are commonly measured both before and after a flow disturbance and the difference is determined. This paper presents data indicating that the LCPDI will be useful for measuring such phase objects. Two wavefronts differing only by the amount of defocus were chosen for measurement by the LCPDI. This phase object was chosen because the focus change can be easily verified by calculation.

The LCPDI currently has the unwanted side-effect of object beam intensity modulation along with phase modulation. Two techniques designed to compensate for this intensity variation are described in this paper. These techniques require the measurement of both the phase shifted interferograms and the object beam intensity distributions at each applied voltage.

#### **Experimental Apparatus and Procedure**

The liquid crystal point diffraction interferometer (LCPDI) consists of dyed parallel nematic liquid crystals sandwiched between two glass plates. A transparent microsphere placed between the glass plates near the center of the clear aperture displaces a small volume of liquid crystal. Coherent light is brought to a focus near the microsphere. The focused spot is larger than the microsphere so some of the beam travels through the liquid crystal forming the object beam. The rest is diffracted by the microsphere and forms the reference beam.

The glass plates have transparent electrodes deposited on their inner surfaces. Leads are soldered onto the electrodes so that an alternating current can be applied across the liquid

crystal. The applied field reorients the liquid crystal molecules and changes the refractive index of the liquid crystal layer. The phase of the object beam can thus be altered without affecting the reference beam.

Dye is added to the liquid crystals in order to attenuate the object beam to roughly the same intensity as the reference beam. This improves the fringe contrast, but the dye molecules rotate with the liquid crystal molecules causing an unwanted intensity modulation when the phase is shifted.

A schematic of the optical system is shown in Fig. 1. A laser beam is brought to focus just before the liquid crystal filter (LCPDI POS1). The LCPDI is tilted to reduce the effects of multiple reflections. The phase shift between the object and reference beams is set to  $j\pi/2$ radians (where j = 0,1,2,3,4) by applying a voltage sequence ranging from 1.04 to 1.55 VAC across the electrodes. The interferograms are formed on a ground glass screen (SCR) placed behind the LCPDI and are recorded with a CCD camera. In order to measure the intensity distribution of the object beam alone, the LCPDI plate was translated by 0.75 mm along the x1-axis so that the focused beam did not pass through any microspheres. The light incident on the screen was recorded for each applied voltage. The amount of defocus was then increased by moving the LCPDI along the optical axis by  $\delta z = 0.34$  mm. Slight in-plane adjustments were made to center the new interference pattern on the CCD. Again, the interferograms were recorded, then the LCPDI plate was translated in order to record the object beam alone.

#### **Data reduction**

Standard algorithms for the extraction of wavefront phase can not be used for these interferogram sequences because the average intensity across each image varies from frame to frame. Two approaches were taken to compensate for this intensity variation. In order to evaluate the performance of these compensation techniques, the wavefronts were first computed from the raw interferograms using Hariharan's 5-frame algorithm[2]. This algorithm was chosen because of its robustness in the presence of phase stepping error.

Each frame of object beam intensity data was smoothed with a boxcar average over 25 pixels to decrease the speckle and multiple beam interference effects in the frames. A 2-D sixth-order polynomial was fitted to each smoothed intensity frame to form normalization frames  $I_i^{obj}$ , where again j = 0, 1, 2, 3, 4.

For the first compensation method, each interferogram  $I_j$  is divided by the appropriate normalization frame, then used in the 5-frame algorithm as follows:

$$\tan(\phi) = 2[I_3/I_3^{obj} - I_1/I_1^{obj}] / [I_0/I_0^{obj} + I_4/I_4^{obj} - 2I_2/I_2^{obj}]$$
(1)

The second method uses the object beam intensity to explicitly solve for the wavefront phase. Assuming that the reference beam intensity remains constant from frame to frame, the wavefront phase  $\phi$  can be calculated as follows:

$$\tan(\phi) = \{ \left[ \Delta I_3 - \Delta I_1 \right] / \left[ \Delta I_0 + \Delta I_4 - 2\Delta I_2 \right] \} * \\ \{ \left[ \operatorname{sqrt}(I_0^{\operatorname{obj}}) + \operatorname{sqrt}(I_4^{\operatorname{obj}}) + 2\operatorname{sqrt}(I_2^{\operatorname{obj}}) \right] / \left[ \operatorname{sqrt}(I_3^{\operatorname{obj}}) + \operatorname{sqrt}(I_1^{\operatorname{obj}}) \right] \}$$
(2)

where  $\Delta I_j = I_j - I_j^{obj}$ .

The wavefronts for both positions of the LCPDI were computed using the standard 5frame algorithm on the raw interferograms and the intensity compensation algorithms given by Eqns. 1 and 2. Also, 2-D polynomials were fitted to the wavefronts computed from the raw interferograms. The wavefront difference was obtained by subtracting the two wavefronts obtained by each of the four methods.

### **Theoretical analysis**

The difference in the optical phase between the wavefronts at each LCPDI position can be calculated from:

$$\Delta\phi_{\rm th}(r,\delta z) = \{ \operatorname{sqrt}(D^2 + r^2) - \operatorname{sqrt}[(D - \delta z)^2 + r^2] - \delta z \} 2\pi/\lambda$$
(3)

where D is the distance from the LCPDI to the ground glass viewing screen,  $\delta z$  is the axial distance between the two positions of the LCPDI, and r is the radial distance from the center of the interferogram.

### Results

Fig. 2 shows horizontal cross sections from the wavefront differences computed using each of the methods described above together with the corresponding cross section from the theoretical wavefront difference calculated from Eqn. 3. It can be seen that in each case the wavefront difference is accurately measured. The standard deviations from the theoretical wavefront for each of the computed wavefront differences are 5.1, 25.4, 14.1, and 14.9 for the wavefront differences computed from: polynomial fits to the wavefronts computed from the 5-frame algorithm, the 5-frame algorithm, Eqn. 1, and Eqn. 2, respectively. Equations 1 and 2 produce similar results and provide significant improvement over the standard 5-frame algorithm. The amount of periodic error is reduced by these intensity compensation algorithms but not eliminated. The frequency of the error is the same as the spatial frequency of the interferogram fringes, indicating that the intensity variations have not yet been completely compensated.

This data shows that a phase object has been accurately measured but that further work is required to eliminate the residual periodic phase measurement error.

#### References

- 1. C.R. Mercer, K. Creath, Optics Letters, to be published (1994).
- 2. P. Hariharan, B. F. Oreb, and T. Eiju, App. Opt., 26, 2504 (1987).



Figure 1.---Schematic of the LCPDI used to measure defocus.



- 2. Raw interferograms
- 3. Normalized interferograms
- 4. Modified equation to include object beam frames

Figure 2.—Horizontal cross sections through wavefront differences calculated using various algorithms. Arbitrary offset added for clarity. Methods used (from bottom to top): (a) polynomial fits to wavefronts computed using 5-frame algorithm, (b) 5-frame algorithm, (c) interferograms normalized with object beam (Eqn. 1), and (d) phase calculated explicitly using object beam (Eqn. 2). Dashed line indicates theoretical value for the wavefront difference.

REPORT DOCUMENTATION PAGE			Form Approved OMB No. 0704-0188
Public reporting burden for this collection of infor gathering and maintaining the data needed, and collection of information, including suggestions fo Data burden using 1004 definition 20 0200	mation is estimated to average 1 hour per completing and reviewing the collection of r reducing this burden, to Washington Hear (200, and to the Office of Management a	response, including the time for rev information. Send comments regar dquarters Services, Directorate for ad Budget Rangework Reduction R	viewing instructions, searching existing data sources, ding this burden estimate or any other aspect of this information Operations and Reports, 1215 Jefferson roject (0274.0188) Washington, DC 20503
1 AGENCY LISE ONLY (Leave blank)	2 REPORT DATE		DATES COVERED
1. AGENCT USE UNLT (Leave Dialik)	August 1994	Te	chnical Memorandum
4. TITLE AND SUBTITLE	Thugust 1774		5. FUNDING NUMBERS
Defocus Measurement Using	a Liquid Crystal Point Diffrac	tion Interferometer	
6. AUTHOR(S) . Carolyn R.Mercer and Kather	ine Creath		WU-505-62-50
7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES)       8.			8. PERFORMING ORGANIZATION REPORT NUMBER
National Aeronautics and Space Administration Lewis Research Center Cleveland, Ohio 44135–3191			E-9043
9. SPONSORING/MONITORING AGENCY NAME(S) AND ADDRESS(ES) 10.			10. SPONSORING/MONITORING AGENCY REPORT NUMBER
National Aeronautics and Space Administration Washington, D.C. 20546–0001			NASA TM-106687
12a. DISTRIBUTION/AVAILABILITY ST Unclassified - Unlimited Subject Category 35	ATEMENT		12b. DISTRIBUTION CODE
13. ABSTRACT (Maximum 200 words)			
A liquid crystal PDI is demon Errors caused by average inte	strated by measuring the defonsity variations are discussed.	cus change between two	positions of the interferometer.
14. SUBJECT TERMS			15. NUMBER OF PAGES
14. SUBJECT TERMS Point diffraction interferomet	ter; Phase shifting; Optical tes	ting	15. NUMBER OF PAGES 06 16. PRICE CODE A02
14. SUBJECT TERMS         Point diffraction interferomet         17. SECURITY CLASSIFICATION         18         OF REPORT	ter; Phase shifting; Optical tes B. SECURITY CLASSIFICATION OF THIS PAGE	ting 19. SECURITY CLASSIFICA OF ABSTRACT	15. NUMBER OF PAGES         06         16. PRICE CODE         A02         TION       20. LIMITATION OF ABSTRACT
14. SUBJECT TERMS         Point diffraction interferomet         17. SECURITY CLASSIFICATION         0F REPORT         Unclassified	ter; Phase shifting; Optical tes <b>5. SECURITY CLASSIFICATION</b> <b>OF THIS PAGE</b> Unclassified	ting 19. SECURITY CLASSIFICA OF ABSTRACT Unclassified	15. NUMBER OF PAGES         06         16. PRICE CODE         A02         TION       20. LIMITATION OF ABSTRACT

¥

۸.

4

۰